

#15  
Dwyatt

BOX PCT  
IN THE UNITED STATES DESIGNATED/ELECTED OFFICE  
OF THE UNITED STATES PATENT AND TRADEMARK OFFICE  
UNDER THE PATENT COOPERATION TREATY--CHAPTER II

APPLICANT(S): ERWIN THURNER  
ATTORNEY DOCKET NO.: P01,0041  
INTERNATIONAL APPLICATION NO: PCT/DE99/02753  
INTERNATIONAL FILING DATE: 01 SEPTEMBER 1999  
INVENTION: METHOD FOR DETERMINING A GRAPHIC STRUCTURE  
OF A TECHNICAL SYSTEM AND ARRANGEMENT AND  
SET OF ARRANGEMENTS FOR DETERMINING A  
GRAPHIC STRUCTURE

Assistant Commissioner for Patents,  
Washington D.C. 20231

**INFORMATION DISCLOSURE STATEMENT**

According to 37 C.F.R. 1.97(b)

Sir:

In accordance with the provisions of 37 C.F.R. 1.56 and the requirements of 37 C.F.R. 1.98, Applicant respectfully requests that a citation and examination of the references identified on the attached PTO 1449 form be made during the course of examination of the above-identified application for United States Patent.

The present Information Disclosure Statement is being filed according to 37 C.F.R. 1.97(b) and before the latter occurrence of:

- (1) three months from the filing date of a national application;
- (2) three months from the date of entry of the national stage as set forth in 37 C.F.R. 1.491 in an international application; or
- (3) the mailing date of a first Office Action on the merits.

**REMARKS**

The attached PTO 1449 form lists related art references for the above identified application, including those identified in the International Search Report, copy of which is enclosed herewith.


### EXPLANATION OF RELEVANCE

Reference AA is a U.S. Patent that was cited in the International Search Report. References AQ-AS were all discussed in the specification. No additional statement of relevance is thus necessary.

The filing of the present Information Disclosure Statement is not to be construed as a representation that a search has been made, and is not to be construed as an admission that the information cited in the present Information Disclosure Statement is, or is considered to be, material to patentability as defined in 37 C.F.R. 1.56(b).

The above citation of prior art is not a representation that such art constitutes a complete or exhaustive listing of all pertinent prior art, nor that it necessarily includes the closest or most relevant art. The aforementioned citation comprises a voluntary citation of prior art of which applicant and his attorney are presently aware and is not intended to serve as a substitute for the Examiners own search.

Submitted by,

  
\_\_\_\_\_  
Mark Bergner (Reg. No. 45,877)  
SCHIFF HARDIN & WAITE  
PATENT DEPARTMENT  
6600 Sears Tower  
Chicago, Illinois 60606-6473  
(312) 258-5779  
Attorney for Applicant(s)

**CUSTOMER NUMBER 26574**

Form P.T.O. 1449 Department of Commerce  
Patent and Trademark Office

Docket No.:  
**P01,0041**

Serial No.  
**New Application**

**LIST OF PRIOR ART CITED BY APPLICANT**  
(use several sheets if necessary)

Applicant(s):

**ERWIN THURNER**

Filing Date  
**Herewith**

Group Art Unit

**U.S. PATENT DOCUMENTS**

Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If appropriate
	AA	5,691,912	November 25, 1997	Duncan			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

**FOREIGN PATENT DOCUMENTS**

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AJ							
	AK							
	AL							
	AM							
	AN							
	AO							
	AP							

**OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

	AQ	Veroeffentlichung im Internet erhaeltlich am 2 September 1998 unter der Adresse: <a href="http://www.redac.co.uk/prod_info/brochures/14a.html">http://www.redac.co.uk/prod_info/brochures/14a.html</a>
	AR	G. Chiola, et al., GreatSPN 1.7: graphical editor and analyzer for timed and stochastic Petri nets, Performance Evaluation, special issue on Performance Modelling Tools, 24 (1&2), pp.47-68, (1995).
	AS	G. Schmidt, Grundlagen der Regelungstechnik: Analyse und Entwurf linearer und einfacher nichtlinearer Regelungen sowie diskreter Steuerungen, zweite Auflage, Springer-Verlag, ISBN 3-540-17112-6, Berlin, pp. 320-328, (1991).
	AT	
	AU	
	AV	
	AW	
	AX	
	AY	

Examiner

Date Considered

**\*EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.